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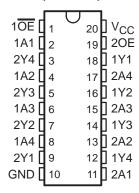
- 3-State Outputs Drive Bus Lines or Buffer Memory Address Registers
- PNP Inputs Reduce DC Loading
- Package Options Include Plastic Small-Outline (DW), Ceramic Chip Carriers (FK), and Standard Plastic and Ceramic 300-mil DIPs (J, N)

description

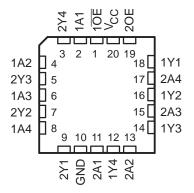
These octal buffers and line drivers are designed specifically to improve both the performance and density of 3-state memory address drivers, clock drivers, and bus-oriented receivers and transmitters. These devices feature high fan-out and improved fan-in.

The SN54ALS241B and SN54AS241 are characterized for operation over the full military temperature range of -55°C to 125°C. The SN74ALS241B and SN74AS241 are characterized for operation from 0°C to 70°C.

SN54ALS241B, SN54AS241 . . . J PACKAGE SN74ALS241B, SN74AS241 . . . DW OR N PACKAGE (TOP VIEW)



SN54ALS241B, SN54AS241 . . . FK PACKAGE (TOP VIEW)



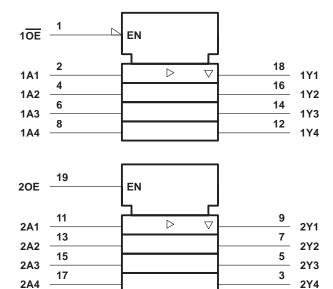
FUNCTION TABLES

	INPU	JTS	OUTPUT
	10E	1A	1Y
Γ	L	Н	Н
ı	L	L	L
L	Н	Χ	Z

INP	JTS	ОИТРИТ
20E	2A	2Y
Н	Н	Н
Н	L	L
L	X	Z

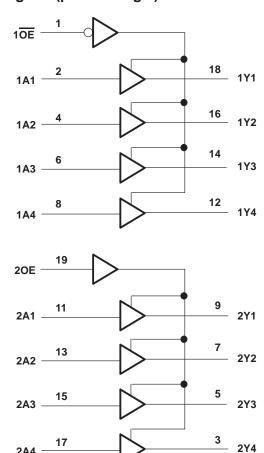
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logic symbol†



[†] This symbol is in accordance with ANSI/IEEE Std 91-1984 and IEC Publication 617-12.

logic diagram (positive logic)



absolute maximum ratings over operating free-air temperature range (unless otherwise noted)‡

Supply voltage, V _{CC}	
Input voltage, V _I	7 \
Voltage applied to a disabled 3-state output	5.5 V
Operating free-air temperature range: SN54ALS241B, SN54AS241	–55°C to 125°C
SN74ALS241B, SN74AS241	0°C to 70°C
Storage temperature range	65°C to 150°C

[‡] Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.



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recommended operating conditions

		SN54ALS241B SN74ALS241B		UNIT				
		MIN	NOM	MAX	MIN	NOM	MAX	UNIT
Vcc	Supply voltage	4.5	5	5.5	4.5	5	5.5	V
VIH	High-level input voltage	2			2			V
V _{IL}	Low-level input voltage			0.7			0.8	V
IOH	High-level output current			-12			-15	mA
lOL	Low-level output current			12			24	mA
TA	Operating free-air temperature	-55		125	0		70	°C

electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

PARAMETER	TEST CONDITIONS		SN5	SN54ALS241B			SN74ALS241B			
PARAMETER			MIN	TYP	MAX	MIN	TYP†	MAX	UNIT	
VIK	V _{CC} = 4.5 V,	$I_{I} = -18 \text{ mA}$			-1			-1	V	
	$V_{CC} = 4.5 \text{ V to } 5.5 \text{ V},$	$I_{OH} = -0.4 \text{ mA}$	V _{CC} -2	!		V _{CC} -2				
\/a		$I_{OH} = -3 \text{ mA}$	2.4	3.2		2.4	3.2		V	
VOH	V _{CC} = 4.5 V	$I_{OH} = -12 \text{ mA}$	2						\ \ \	
		$I_{OH} = -15 \text{ mA}$				2				
V	V _{CC} = 4.5 V	I _{OL} = 12 mA		0.25	0.4				V	
VOL		$I_{OL} = 24 \text{ mA}$					0.25	0.4	V	
lozh	$V_{CC} = 5.5 \text{ V},$	$V_0 = 2.7 \text{ V}$			20			20	μΑ	
lozL	V _{CC} = 5.5 V,	V _O = 0.4 V			-20			-20	μΑ	
ΙĮ	V _{CC} = 5.5 V,	V _I = 7 V			0.1			0.1	mA	
lіН	V _{CC} = 5.5 V,	V _I = 2.7 V			20			20	μΑ	
I _{IL}	V _{CC} = 5.5 V,	V _I = 0.4 V			-0.1			-0.1	mA	
1 ₀ ‡	V _{CC} = 5.5 V,	V _O = 2.25 V	-20		-112	-30		-112	mA	
		Outputs high		9	17		9	15		
Icc	V _{CC} = 5.5 V	Outputs low		15	28		15	26	mA	
		Outputs disabled		17	32		17	30		

[†] All typical values are at $V_{CC} = 5 \text{ V}$, $T_A = 25^{\circ}\text{C}$.



[‡] The output conditions have been chosen to produce a current that closely approximates one half of the true short-circuit output current, IOS.

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switching characteristics (see Figure 1)

PARAMETER	FROM TO (INPUT) (OUTPUT)		F F	UNIT			
			SN54AI	LS241B	SN74AI	LS241B	
			MIN	MAX	MIN	MAX	
^t PLH	А	Υ	3	31	3	11	ns
t _{PHL}	A	I	1	17	3	10	115
^t PZH	1 0E	Υ	3	33	5	21	ns
^t PZL	TOE	'	3	27	5	21	113
^t PHZ	1 0E	Y	2	17	2	10	ns
t _{PLZ}	10E	Y	2	32	2	15	115
^t PZH	205	Υ	3	38	5	21	200
^t PZL	20E	T	3	30	5	21	ns
^t PHZ	2OE	Υ	2	17	2	10	ne
tPLZ	ZUE	2OE Y	3	35	3	15	ns

[†] For conditions shown MIN or MAX, use the appropriate value specified under recommended operating conditions.

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recommended operating conditions

		SN54AS241		SI	UNIT			
		MIN	NOM	MAX	MIN	NOM	MAX	UNIT
VCC	Supply voltage	4.5	5	5.5	4.5	5	5.5	V
VIH	High-level input voltage	2			2			V
V _{IL}	Low-level input voltage			0.8			0.8	V
IOH	High-level output current			-12			-15	mA
lOL	Low-level output current			48			64	mA
TA	Operating free-air temperature	-55		125	0		70	°C

electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

PARAMETER	TEST CONDITIONS		SN	SN54AS241		SN	UNIT		
PARAMETER			MIN	TYP [†]	MAX	MIN	TYP†	MAX	UNIT
VIK	V _{CC} = 4.5 V,	$I_{I} = -18 \text{ mA}$			-1			-1	V
	\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\	$I_{OH} = -2 \text{ mA}$	V _{CC} -2			V _{CC} -2			
Vari	V _{CC} = 4.5 V to 5.5 V	$I_{OH} = -3 \text{ mA}$	2.4	3.4		2.4	3.4		V
VOH	V00 - 45 V	I _{OH} = -12 mA	2.4						V
	V _{CC} = 4.5 V	$I_{OH} = -15 \text{ mA}$				2.4			
Va	$V_{CC} = 4.5 \text{ V},$	$I_{OL} = 48 \text{ mA}$		0.27	0.55				V
VOL	$V_{CC} = 4.75 \text{ V},$	$I_{OL} = 64 \text{ mA}$					0.31	0.55	l v
lоzн	V _{CC} = 5.5 V,	V _O = 2.7 V			50			50	μΑ
lozL	V _{CC} = 5.5 V,	V _O = 0.4 V			-50			-50	μΑ
lį	V _{CC} = 5.5 V,	V _I = 7 V			0.1			0.1	mA
lін	V _{CC} = 5.5 V,	V _I = 2.7 V			20			20	μΑ
IIL	V _{CC} = 5.5 V,	V _I = 0.4 V			-1			-1	mA
1 ₀ ‡	V _{CC} = 5.5 V,	V _O = 2.25 V	-50		-150	-50		-150	mA
	V _{CC} = 5.5 V	Outputs high		22	35		22	35	
Icc		Outputs low		61	90		61	90	mA
		Outputs disabled		35	56		35	56	

[†] All typical values are at $V_{CC} = 5 \text{ V}$, $T_A = 25^{\circ}\text{C}$.

[‡] The output conditions have been chosen to produce a current that closely approximates one half of the true short-circuit output current, IOS.

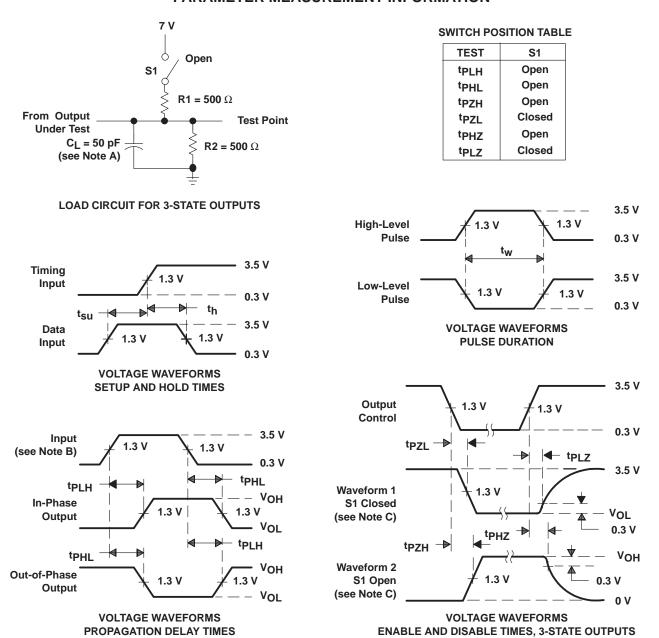
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switching characteristics (see Figure 1)

PARAMETER	FROM (INPUT)	ТО (ОИТРИТ)	V _i C R R T	UNIT			
			SN54AS241		SN74AS241		
		+	MIN	MAX	MIN	MAX	
^t PLH	А	Y	2	9	2	6.2	ns
^t PHL		•	2	7	2	6.2	113
^t PZH	1 OE	Y	2	10	2	9	ns
tPZL	10E	1	2	8	2	7.5	113
^t PHZ	1 0E	Y	2	6.5	2	6	
t _{PLZ}	10E	Y	2	10.5	2	9	ns
^t PZH	205	Y	2	11	3	10.5	
t _{PZL}	20E	1	3	9.5	3	8.5	ns
^t PHZ	20E	Y	3	7	3	7	
t _{PLZ}	20E	1	3	12	3	12	ns

[†] For conditions shown MIN or MAX, use the appropriate value specified under recommended operating conditions.

PARAMETER MEASUREMENT INFORMATION



NOTES: A. C_L includes probe and jig capacitance.

- B. All input pulses are supplied by generators having the following characteristics: PRR \leq 1 MHz, $Z_0 = 50 \Omega$, $t_f \leq$ 2 ns, $t_f \leq$ 2 ns.
- C. Waveform 1 is for an output with internal conditions such that the output is low except when disabled by the output control. Waveform 2 is for an output with internal conditions such that the output is high except when disabled by the output control.
- D. The outputs are measured one at a time with one transition per measurement.

Figure 1. Load Circuit and Voltage Waveforms



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